

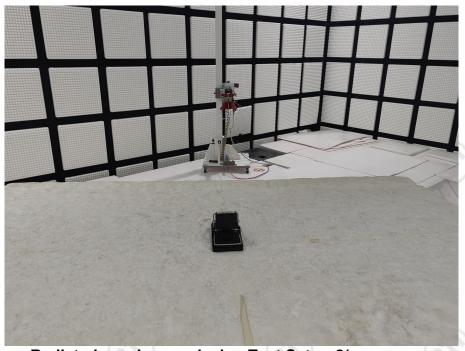


Report No. :EED32O81366901





Radiated spurious emission Test Setup-1(Below 1GHz)



Radiated spurious emission Test Setup-2(Above 1GHz)













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